## Triple Analog Video Delay Lines

The ISL59920, ISL59921, ISL59922, and ISL59923 are triple analog delay lines that provide skew compensation between three high-speed signals. These parts are ideal for compensating for the skew introduced by a typical CAT-5, CAT-6 or CAT-7 cable (with differing electrical lengths on each twisted pair) when transmitting analog video.

Using a simple serial interface, the ISL59920, ISL59921, ISL59922, and ISL59923's delays are programmable in steps of $2,1.5,1$, or 2 ns (respectively) for up to a total delay of $62,46.5,31$, or 30 ns (respectively) on each channel. The gain of the video amplifiers can be set to $x 1$ ( 0 dB ) or x 2 ( 6 dB ) for back-termination. The delay lines require a $\pm 5 \mathrm{~V}$ supply.

## Features

- 30, 31, 46.5, or $62 n s$ Total Delay
- 1.0, 1.5, or 2.0ns Delay Step Increments
- Very Low Offset Voltage
- Drop-in Compatible with the EL9115
- Low Power Consumption
- 20 Ld QFN Package
- Pb-Free (RoHS Compliant)


## Applications

- Skew Control for RGB Video Signals
- Generating Programmable High-speed Analog Delays


## Ordering Information

| PART NUMBER <br> (Note) | PART <br> MARKING | MAX <br> DELAY <br> (ns) | DELAY STEP <br> SIZE (ns) | TYPICAL POWER <br> DISSIPATION <br> $(\mathbf{m W})$ | PACKAGE <br> (Pb-free) |
| :--- | :--- | :---: | :---: | :---: | :--- | :--- |
| ISL59920IRZ* | 59920 IRZ | 62 | 2.0 | 645 | 20 Ld 5mmx5mm QFN |
| DWG. \# |  |  |  |  |  |

*Add "-T7" suffix for tape and reel. Please refer to TB347 for details on reel specifications.
NOTE: These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and $100 \%$ matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb -free soldering operations). Intersil Pb -free products are MSL classified at Pb -free peak reflow temperatures that meet or exceed the Pb -free requirements of IPC/JEDEC J STD-020.

## Pinout



| Absolute Maximum Ratings ( $\left.\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}\right)$ |  |
| :---: | :---: |
| Supply Voltage ( $\mathrm{V}_{\mathrm{S}^{+}}$to $\mathrm{V}_{\mathrm{S}^{-}}$) | 12 V |
| Maximum Output Current. | $\pm 60 \mathrm{~mA}$ |
| Storage Temperature Range | $65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| ESD Classification |  |
| Human Body Model | 3000 V |
| Machine Model. | .300V |
| Charged Device Model. | 1200V |

## Thermal Information

| Thermal Resistance (Typical, Note 1) | $\theta_{\mathrm{JA}}(\mathrm{C} / \mathrm{W})$ |
| :---: | :---: |
| 20 Lead QFN | 31 |
| Pb-Free Reflow Profile. | ee link below |

## Recommended Operating Conditions

Operating Junction Temperature $\qquad$ . $+135^{\circ} \mathrm{C}$ Ambient Operating Temperature . . . . . . . . . . . . . . . . . $40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.
NOTE:

1. $\theta_{\mathrm{JA}}$ is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

IMPORTANT NOTE: All parameters having Min/Max specifications are guaranteed. Typical values are for information purposes only. Unless otherwise noted, all tests are at the specified temperature and are pulsed tests, therefore: $T_{J}=T_{C}=T_{A}$

Electrical Specifications $\quad V_{S P}=V_{S P O}=+5 \mathrm{~V}, V_{S M}=V_{S M P}=-5 \mathrm{~V}, \mathrm{GAIN}=2, T_{A}=+25^{\circ} \mathrm{C}$, exposed die plate $=-5 \mathrm{~V}, \mathrm{x} 2=5 \mathrm{~V}$,
$R_{\text {LOAD }}=150 \Omega$ on all video outputs, unless otherwise specified.

| PARAMETER | DESCRIPTION | CONDITION | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{d}_{\mathrm{t}}$ | Nominal Delay Increment (Note 2) | ISL59920 | 1.8 | 2 | 2.2 | ns |
|  |  | ISL59921 | 1.4 | 1.5 | 1.7 | ns |
|  |  | ISL59922 | 0.9 | 1 | 1.2 | ns |
|  |  | ISL59923 | 1.8 | 2 | 2.3 | ns |
| $\mathrm{t}_{\text {MAX }}$ | Maximum Delay | ISL59920 | 55 | 62 | 68 | ns |
|  |  | ISL59921 | 42.5 | 46.5 | 53.5 | ns |
|  |  | ISL59922 | 26.5 | 31 | 38.5 | ns |
|  |  | ISL59923 | 26.5 | 30 | 34.5 | ns |
| DELDT | Delay Difference Between Channels for Same Delay Settings On All Channels |  |  | 1 |  | ns |
| tPD | Propagation Delay | ISL59920, ISL59923, measured input to output, delay setting = Ons |  | 10 |  | ns |
|  |  | ISL59921, measured input to output, delay setting $=0 n s$ |  | 8 |  | ns |
|  |  | ISL59922, measured input to output, delay setting $=0 n s$ |  | 7 |  | ns |
| BW -3dB | 3dB Bandwidth, Ons Delay Time | ISL59920, ISL59923 |  | 153 |  | MHz |
|  |  | ISL59921 |  | 200 |  | MHz |
|  |  | ISL59922 |  | 230 |  | MHz |
| BW $\pm 0.1 \mathrm{~dB}$ | $\pm 0.1 \mathrm{~dB}$ Bandwidth, Ons Delay Time | ISL59920, ISL59923 |  | 50 |  | MHz |
|  |  | ISL59921 |  | 60 |  | MHz |
|  |  | ISL59922 |  | 50 |  | MHz |
| SR | Slew Rate | ISL59920, 20-80, delay $=$ Ons |  | 550 |  | V/us |
|  |  | ISL59921, 20-80, delay $=0 \mathrm{~ns}$ |  | 640 |  | V/us |
|  |  | ISL59922, 20-80, delay $=0 \mathrm{~ns}$ |  | 700 |  | V/us |
|  |  | ISL59923; 20-80, delay $=$ Ons |  | 550 |  | V/us |

Electrical Specifications $\quad V_{S P}=V_{S P O}=+5 \mathrm{~V}, \mathrm{~V}_{\mathrm{SM}}=\mathrm{V}_{\mathrm{SMP}}=-5 \mathrm{~V}$, GAIN $=2, \mathrm{~T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, exposed die plate $=-5 \mathrm{~V}$, $\mathrm{x} 2=5 \mathrm{~V}$,
$R_{\text {LOAD }}=150 \Omega$ on all video outputs, unless otherwise specified. (Continued)

| PARAMETER | DESCRIPTION | CONDITION | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{R}}-\mathrm{t}_{\mathrm{F}}$ | Transient Response Time | ISL59920, 20\% to 80\%, for any delay, 1V step delay $=0 \mathrm{~ns}$ |  | 1.7 |  | ns |
|  |  | ISL59921, 20\% to 80\%, for any delay, 1V step delay $=0 n s$ |  | 1.6 |  | ns |
|  |  | ISL59922, 20\% to 80\%, for any delay, 1V step delay $=0 \mathrm{~ns}$ |  | 1.43 |  | ns |
|  |  | ISL59923, 20\% to 80\%, for any delay, 1V step delay $=0 \mathrm{~ns}$ |  | 1.7 |  | ns |
| V oVER | Voltage Overshoot | For any delay, response to 1V step input |  | 4 |  | \% |
| Settling Time | Output Settling after Delay Change / Offset Calibration | Output settling time from rising edge of SENABLE |  | 3 |  | $\mu \mathrm{s}$ |
| THD | Total Harmonic Distortion | $1 \mathrm{~V}_{\mathrm{P}-\mathrm{P}} 10 \mathrm{MHz}$ sinewave, offset by +0.2 V at mid delay setting |  | -43 | -38 | dB |
| X | Crosstalk | Stimulate G, measure R/B at 1 MHz , ISL59920, ISL59921, ISL59923 |  | -80 | -63 | dB |
|  |  | ISL59922 |  | -78 | -59 | dB |
| $\mathrm{V}_{\mathrm{N}}$ | Output Noise | Bandwidth $=150 \mathrm{MHz}$ |  | 2 |  | $\mathrm{mV}_{\text {RMS }}$ |
| G_0 | Gain Zero Delay |  | 1.74 | 1.8 | 1.92 | V/V |
| G_m | Gain Mid Delay |  | 1.67 | 1.8 | 1.97 | V/V |
| G_f | Gain Full Delay |  | 1.6 | 1.8 | 2 | V/V |
| DG_m0 | Difference in Gain, 0 to Mid |  | -8 | 0.6 | 7.5 | \% |
| DG_f0 | Difference in Gain, 0 to Full |  | -12 | -1.8 | 10 | \% |
| DG_fm | Difference in Gain, Mid to Full |  | -10 | -1.7 | 7.5 | \% |
| $\mathrm{V}_{\text {IN }}$ | Input Voltage Range | ISL59920, Gain remains > 90\% of nominal, Gain $=2$ | -0.7 |  | 1.1 | V |
|  |  | ISL59921, Gain remains > 90\% of nominal, Gain = 2 | -0.7 |  | 1.04 | V |
|  |  | ISL59922, Gain remains > 90\% of nominal, Gain = 2 | $-0.7$ |  | 1.04 | V |
|  |  | ISL59923, Gain remains > 90\% of nominal, Gain = 2 | -0.7 |  | 1.15 | V |
| $\mathrm{I}_{\mathrm{B}}$ | $\mathrm{R}_{\text {IN }}, \mathrm{G}_{\text {IN }}, \mathrm{B}_{\text {IN }}$ Input Bias Current | ISL59920, ISL59921 | 3 | 6 | 8 | $\mu \mathrm{A}$ |
|  |  | ISL59922, ISL59923 | 1.5 |  | 8 | $\mu \mathrm{A}$ |
| VOS | Output Offset Voltage | Post offset calibration (Note 4), Delay = Ons and Delay = Full | -25 | -4 | +20 | mV |
| Z OUT | Output Impedance | ISL59920, ISL59921, Enabled, Chip enable $=5 \mathrm{~V}$ | 4.5 | 5.4 | 6.3 | $\Omega$ |
|  |  | ISL59922, ISL59923, Enabled, Chip enable $=5 \mathrm{~V}$ | 3.5 |  | 6.3 | $\Omega$ |
|  |  | Disabled, Chip enable $=0 \mathrm{~V}$ |  | 8 |  | $\mathrm{M} \Omega$ |
| +PSRR | Rejection of Positive Supply |  |  | -42 | -29 | dB |
| -PSRR | Rejection of Negative Supply |  |  | -58 | -46 | dB |
| Iout | Output Drive Current | $10 \Omega$ load, 0.5 V drive | 43 | 53 | 70 | mA |
| $\mathrm{V}_{\mathrm{IH}}$ | Logic High | Switch high threshold |  |  | 1.6 | V |
| $\mathrm{V}_{\text {IL }}$ | Logic Low | Switch low threshold | 0.8 |  |  | V |

Electrical Specifications $\quad V_{S P}=V_{S P O}=+5 \mathrm{~V}, \mathrm{~V}_{S M}=\mathrm{V}_{\text {SMP }}=-5 \mathrm{~V}$, GAIN $=2, T_{A}=+25^{\circ} \mathrm{C}$, exposed die plate $=-5 \mathrm{~V}$, $\mathrm{x} 2=5 \mathrm{~V}$,
$R_{\text {LOAD }}=150 \Omega$ on all video outputs, unless otherwise specified. (Continued)

| PARAMETER | DESCRIPTION | CONDITION | MIN | TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| POWER SUPPLY CHARACTERISTICS |  |  |  |  |  |  |
| V+ | $\mathrm{V}_{\text {SP }}$, $\mathrm{V}_{\text {SPO }}$ Positive Supply Range |  | +4.5 |  | +5.5 | V |
| V- | $\mathrm{V}_{\text {SM }}$, $\mathrm{V}_{\text {SMO }}$ Negative Supply Range |  | -4.5 |  | -5.5 | V |
| ISP | Positive Supply Current (Note 3) | ISL59920 | 98 | 115 | 127 | mA |
|  |  | ISL59921, ISL59922 | 98 | 125 | 146 | mA |
|  |  | ISL59923 | 74 | 90 | 106 | mA |
| ISPO | Positive Output Supply Current (Note 3) | ISL59920 | 11.3 | 13 | 15.3 | mA |
|  |  | ISL59921, ISL59922 | 11.3 | 13 | 16.3 | mA |
|  |  | ISL59923 | 9.9 | 13 | 16 | mA |
| ISM | Negative Supply Current (Note 3) |  | -35.45 | -31 | -26 | mA |
| ISMO | Negative Output Supply Current (Note 3) | ISL59920, ISL59921, ISL59922 | -15.5 | -13 | -11 | mA |
|  |  | ISL59923 | -17.5 | -13 | -9.5 | mA |
| $\Delta^{\text {I }} \mathrm{SP}$ | Supply Current (Note 3) | Increase in ISP per unit step in delay per channel |  | 0.9 |  | mA |
| IStandby | Positive Supply Standby Current (Note 3) | Chip enable $=0 \mathrm{~V}$ |  | 2.6 |  | mA |
| SERIAL INTERFACE CHARACTERISTICS |  |  |  |  |  |  |
| $\mathrm{t}_{\text {M }}$ X | Max SCLOCK Frequency | Maximum programming clock speed |  |  | 10 | MHz |
| tsEn_SETUP | SENABLE to SCLOCK falling edge setup time. See Figure 33. | SENABLE falling edge should occur at least tSEN SETUP ns after previous (ignored) clock and tisen SETUP before next (desired) clock. Clock edges occurring within t_en_ck of the SENABLE falling edge will have indeterminate effect. |  | 10 |  | ns |
| tsen_CYCLE | Minimum Separation Between $\overline{\text { SENABLE }}$ rising edge and next $\overline{\text { SENABLE }}$ falling edge. See Figure 33. | If $\overline{\text { SENABLE }}$ is taken low less than $3 \mu$ s after it was taken high, there is a small possibility that an offset correction will not be initiated. | 3 |  |  | $\mu \mathrm{s}$ |

## NOTES:

2. The limits for the "Nominal Delay Increment" are derived by taking the limits for the "Maximum Delay" and dividing by the number of steps for the device. For the ISL59920, ISL59921, and ISL59922 the number of steps is 31 ; for the ISL59923 the number of steps is 15 .
3. All supply currents measured with Delay $R=0 n s, G=$ mid delay, $B=$ full delay.
4. Offset measurements are referred to $75 \Omega$ load as shown in Figure 1.


FIGURE 1. $\mathrm{V}_{\text {OS }}$ MEASUREMENT CONDITIONS

## Pin Descriptions

| PIN NUMBER | PIN NAME | PIN DESCRIPTION |
| :---: | :---: | :---: |
| 1 | $\mathrm{V}_{\text {SP }}$ | +5V for delay circuitry and input amp |
| 2 | $\mathrm{R}_{\text {IN }}$ | Red channel video input |
| 3 | GND | OV for delay circuitry supply |
| 4 | $G_{I N}$ | Green channel video input |
| 5 | $\mathrm{V}_{\text {SM }}$ | -5V for input amp |
| 6 | $\mathrm{BIN}^{\text {N }}$ | Blue channel video input |
| 7 | CENABLE | Chip Enable input, active high: logical high enables chip, low disables chip |
| 8 | $\overline{\text { SENABLE }}$ | Serial Enable input, active low: logical low enables serial communication |
| 9 | SDATA | Serial Data input, logic threshold 1.2V: data to be programmed into chip |
| 10 | SCLOCK | Serial Clock input: Clock to enter data; logical; data written on negative edge |
| 11 | Bout | Blue channel video output |
| 12 | $\mathrm{V}_{\text {SMO }}$ | -5 V for video output buffers |
| 13 | Gout | Green channel video output |
| 14 | GNDO | OV reference for input and output buffers |
| 15 | R OUT | Red channel video output |
| 16 | $\mathrm{V}_{\text {SPO }}$ | +5V for video output buffers |
| 17 | TESTB | Blue channel phase detector output |
| 18 | TESTG | Green channel phase detector output |
| 19 | TESTR | Red channel phase detector output |
| 20 | X2 | Gain Select Input: logical high = $2 \mathrm{x}(+6 \mathrm{~dB}$ ), logical low $=1 \mathrm{x}(0 \mathrm{~dB})$ |
| Thermal Pad |  | MUST be tied to -5 V . For best thermal conductivity also tie to a larger -5 V copper plane (inner or bottom). Use many vias to minimize thermal resistance between thermal pad and copper plane. Do not connect to GND - connection to GND is equivalent to shorting the -5V and GND planes together. |

## Typical Performance Curves



FIGURE 2. ISL59920 FREQUENCY RESPONSE (GAIN = 1)


FIGURE 4. ISL59921 FREQUENCY RESPONSE (GAIN = 1)


FIGURE 6. ISL59922 FREQUENCY RESPONSE (GAIN = 1)


FIGURE 3. ISL59920 FREQUENCY RESPONSE (GAIN = 2)


FREQUENCY (Hz)
FIGURE 5. ISL59921 FREQUENCY RESPONSE (GAIN = 2)


FIGURE 7. ISL59922 FREQUENCY RESPONSE (GAIN = 2)

## Typical Performance Curves (Continued)



FIGURE 8. ISL59923 FREQUENCY RESPONSE (GAIN = 1)


FIGURE 10. OFFSET CORRECTION DAC ADJUST


FIGURE 12. ISL59921 NOISE SPECTRUM (10k TO 500MHz)


FIGURE 9. ISL59923 FREQUENCY RESPONSE (GAIN = 2)


FIGURE 11. ISL59920 NOISE SPECTRUM (10k TO 500MHz)


FIGURE 13. ISL59922 NOISE SPECTRUM (10k TO 500MHz)

Typical Performance Curves (Continued)


FIGURE 14. ISL59923 NOISE SPECTRUM (10k TO 500MHz)


FIGURE 16. ISL59921 RISE/FALL TIME vs DELAY TIME (GAIN = 2)


FIGURE 18. ISL59923 RISE/FALL TIME vs DELAY TIME (GAIN = 2)


FIGURE 15. ISL59920 RISE/FALL TIME vs DELAY TIME (GAIN = 2)


FIGURE 17. ISL59922 RISE/FALL TIME vs DELAY TIME (GAIN = 2)


FIGURE 19. HARMONIC DISTORTION vs FREQUENCY

## Typical Performance Curves (Continued)



FIGURE 20. ISL59920 POSITIVE SUPPLY CURRENT (VSP) vs DELAY TIME


FIGURE 22. ISL59922 POSITIVE SUPPLY CURRENT (VSP) vs DELAY TIME


FIGURE 24. ISL59920 ${ }^{\text {SUPPLY+ }}{ }^{\text {vs }} \mathrm{V}_{\text {SUPPLY+ }}$


FIGURE 21. ISL59921 POSITIVE SUPPLY CURRENT (VSP) vs DELAY TIME


FIGURE 23. ISL59923 POSITIVE SUPPLY CURRENT (VSP) vs DELAY TIME


FIGURE 25. ISL59920 ISUPPLY$^{-}$vs $\mathrm{V}_{\text {SUPPLY }}{ }^{-}$

## Typical Performance Curves (Continued)



FIGURE 26. ISL59921 ISUPPLY+ vs $\mathrm{V}_{\text {SUPPLY+ }}{ }^{+}$


FIGURE 28. ISL59922 ISUPPLY+ $^{\text {vs }} \mathrm{V}_{\text {SUPPLY+ }}+$


ISL59923 ISUPPLY $^{+}$vs $\mathrm{V}_{\text {SUPPLY }}{ }^{+}$


FIGURE 27. ISL59921 ISUPPLY- vs VSUPPLY-


FIGURE 29. ISL59922 ISUPPLY- vs VSUPPLY-


FIGURE 30. ISL59923 ISUPPLY- vs $V_{\text {SUPPLY }}{ }^{-}$

## Typical Performance Curves (Continued)



FIGURE 31. PACKAGE POWER DISSIPATION vs AMBIENT TEMPERATURE


FIGURE 32. ISL59920, ISL59921, ISL59922, ISL59923 BLOCK DIAGRAM

## Applications Information

The ISL59920, ISL59921, ISL59922, and ISL59923 are triple analog delay lines that provide skew compensation between three high-speed signals. These devices compensate for time skew introduced by a typical CAT-5, CAT-6 or CAT-7 cable with differing electrical lengths (due to different twist ratios) on each pair. Via their SPI interface, these devices can be programmed to independently compensate for the three different cable delays while maintaining 80 MHz bandwidth at their maximum setting. There are four different variations of the ISL5992x (ISL5992x will be used when talking about characteristics that are common to all four devices).

TABLE 1.

| PART NUMBER | MAX DELAY <br> (ns) | NOMINAL DELAY <br> INCREMENT <br> (ns) |
| :---: | :---: | :---: |
| ISL59920 | 62 | 2.0 |
| ISL59921 | 46.5 | 1.5 |
| ISL59922 | 31 | 1.0 |
| ISL59923 | 30 | 2.0 |



FIGURE 33. SERIAL TIMING

Figure 32 shows the ISL5992x block diagram. The 3 analog inputs are ground referenced single-ended signals. After the signal is received, the delay is introduced by switching filter blocks into the signal path. Each filter block is an all-pass filter introducing either 1, 1.5 or 2 ns of delay. In addition to adding delay, each filter block also introduces some low pass filtering. As a result, the bandwidth of the signal path decreases from the Ons delay setting to the maximum delay setting, as shown in Figures 2 through 9 of the "Typical Performance Curves".

In operation, it is best to allocate the most delayed signal Ons delay then increase the delay on the other channels to bring them into line. This will result in delay compensation with the lowest power and distortion.

## Serial Bus Operation

The ISL5992x is programmed via 8-bit words sent through its serial interface. The first bit (MSB) of SDATA is latched on the first falling clock edge after SENABLE goes low, as shown in Figure 33. This bit should be a 0 under all conditions. The next two bits determine the color register to be written to: $01=\mathrm{R}, 02=\mathrm{G}$, and $03=\mathrm{B}$ ( 00 is reserved for the test register). The final five bits set the delay for the specified color. After 8 bits are latched, any additional clocks are treated as a new word (data is shifted directly to the final registers as it is clocked in). This allows the user to write (for example) the 24 bits of data necessary for R, G, and B as a single 24-bit word. It is the user's responsibility to send complete multiples of 8 clock cycles. The serial state machine is reset on the falling edge of $\overline{\text { SENABLE }}$, so any data corruption that may have occurred due to too many or too few clocks can be corrected with a new word with the correct number of clocks. The initial value of all registers on power-up is 0 .

TABLE 2. SERIAL BUS DATA

| vwxyz | ISL59920 <br> DELAY | ISL59921 <br> DELAY | ISL59922 <br> DELAY | ISL59923 <br> DELAY |
| :---: | :---: | :---: | :---: | :---: |
| 00000 | 0 | 0 | 0 | 0 |
| 00001 | 2 | 1.5 | 1 | 2 |
| 00010 | 4 | 3 | 2 | 4 |
| 00011 | 6 | 4.5 | 3 | 6 |

TABLE 2. SERIAL BUS DATA (Continued)

| vwxyz | $\begin{aligned} & \text { ISL59920 } \\ & \text { DELAY } \end{aligned}$ | $\begin{aligned} & \text { ISL59921 } \\ & \text { DELAY } \end{aligned}$ | $\begin{aligned} & \text { ISL59922 } \\ & \text { DELAY } \end{aligned}$ | $\begin{aligned} & \text { ISL59923 } \\ & \text { DELAY } \end{aligned}$ |
| :---: | :---: | :---: | :---: | :---: |
| 00100 | 8 | 6 | 4 | 8 |
| 00101 | 10 | 7.5 | 5 | 10 |
| 00110 | 12 | 9 | 6 | 12 |
| 00111 | 14 | 10.5 | 7 | 14 |
| 01000 | 16 | 12 | 8 | 16 |
| 01001 | 18 | 13.5 | 9 | 18 |
| 01010 | 20 | 15 | 10 | 20 |
| 01011 | 22 | 16.5 | 11 | 22 |
| 01100 | 24 | 18 | 12 | 24 |
| 01101 | 26 | 19.5 | 13 | 26 |
| 01110 | 28 | 21 | 14 | 28 |
| 01111 | 30 | 22.5 | 15 | 30 |
| 10000 | 32 | 24 | 16 | N/A |
| 10001 | 34 | 25.5 | 17 | N/A |
| 10010 | 36 | 27 | 18 | N/A |
| 10011 | 38 | 28.5 | 19 | N/A |
| 10100 | 40 | 30 | 20 | N/A |
| 10101 | 42 | 31.5 | 21 | N/A |
| 10110 | 44 | 33 | 22 | N/A |
| 10111 | 46 | 34.5 | 23 | N/A |
| 11000 | 48 | 36 | 24 | N/A |
| 11001 | 50 | 37.5 | 25 | N/A |
| 11010 | 52 | 39 | 26 | N/A |
| 11011 | 54 | 40.5 | 27 | N/A |
| 11100 | 56 | 42 | 28 | N/A |
| 11101 | 58 | 43.5 | 29 | N/A |
| 11110 | 60 | 45 | 30 | N/A |
| 11111 | 62 | 46.5 | 31 | N/A |

NOTE: Delay register word = Oabvwxyz; Red register $-\mathrm{ab}=01$; Green register $-\mathrm{ab}=10$; Blue register $-\mathrm{ab}=11$; vwxyz selects delay; $a b=00$ writes to the test register to change the DAC slice level.

## Offset Compensation

To counter the effects of offset, the ISL5992x incorporates an offset compensation circuit that reduces the offset to less than $\pm 25 \mathrm{mV}$. An offset correction cycle is triggered by the rising edge of the SENABLE pin after writing a delay word to any of the 3 channels. The offset calibration starts about 500 ns after the $\overline{\text { SENABLE }}$ rising edge to allow the ISL5992x time to settle (electrically and thermally) to the new delay setting. It lasts about $2.5 \mu \mathrm{~s}$, for a total offset correction time of $3.0 \mu \mathrm{~s}$. During calibration, the ISL5992x's inputs are internally shorted together (however the characteristics of the ISL5992x's differential input pins stay the same), and the offset of the output stage is adjusted until it has been minimized.
In addition to automatically triggering after a delay change (or any register write), an additional offset calibration may be initiated at any time, such as:

- When the die temperature changes. Applying power to the ISL5992x will cause the die temperature to quickly increase then slowly settle over 20 to 30ns. Because the ISL5992x powers-down unused delay stages (to minimize power consumption), the die temp will also change and settle after a delay change. Initiating an offset 20 ns (or longer, depending on the thermal characteristics of the system) after power-on or a delay change will minimize the offset in normal operation thereafter.
- When the ambient temperature changes. If you are monitoring the temperature, initiate a calibration every time the temperature shifts by 5 to 10 degrees. If you are not monitoring temperature, initiate a calibration periodically, as expected by the environment the device is in.
- After a CENABLE (Chip Enable) cycle. The CENABLE pin may be taken low to put the ISL5992x in a low power standby mode to conserve power when not needed. When the CENABLE pin goes high to exit this low power mode, the ISL5992x will recall the delay settings but it will not recall the correct offset calibration settings, so to maintain low offset, a write to the delay register is required after a CENABLE cycle. Offset errors may be as large as $\pm 200 \mathrm{mV}$ coming out of standby mode - recalibration is a necessity. For best performance, initiate an additional calibration again once the die temperature has settled (20 to 30 ns after coming out of standby).
- After a gain change (X2 pin changes state). The systematic offset is different for a gain of $x 1$ vs. a gain of $x 2$, so an offset calibration is recommended after a gain change. However in a typical application the gain is permanently fixed at $x 1$ or $x 2$, so this is not usually a concern.


## Offset Calibration with Sync-On-Video

The offset correction mechanism temporarily disconnects the input signals to perform the offset calibration. This introduces several discontinuities in the video signal, as shown in Figure 10 on page 7:

- $200-300 \mathrm{mV}$ spike when calibration is engaged
- Successive-approximation offset null
- $200-300 \mathrm{mV}$ spike when calibration is disengaged
- In addition, because an offset calibration is performed any time the delay changes, the output video signal may be moved forward or back in time by up to 62ns.

If the video signals going through the ISL5992x contain only video (with no sync signals), this appears as a $2 \mu \mathrm{~s}$ "sparkle" on the screen - usually it is not even visible to the eye.
However if sync signals are embedded on the video, the spikes may be misinterpreted as a sync signal, causing the downstream circuitry to see an asynchronous sync pulse. In some receiving systems (typically monitors), a single asynchronous sync pulse can cause the system to think the video signal has changed. Depending on the receiveing monitor's design, this can initiate a new video acquisition cycle (for example, the monitor blanks the screen while it measures the "new" HSYNC and VSYNC timing, selects the right mode, and optimizes the image). This can cause the monitor to go blank for up to several seconds after a single delay change.
Since this only happens at power-on and when the delays are initially set, this is not a problem in normal use, but if the monitor is blanking for several seconds every time the delay is adjusted, it can cause calibration to take longer than absolutely necessary. If this behavior is undesirable, it can be eliminated as follows:

1. Synchronize the rising edge of SENABLE to the sync pulse, so that the SENABLE goes high immediately after the trailing edge of the sync pulse. SENABLE can be taken low and the serial data written asynchronously at any time - it is the rising edge of SENABLE that triggers a calibration.
2. If the Sync Processor is part of the same design as ISL5992x, ensure that the sync processor ignores the first $x$ microseconds after a valid sync, where $x=3 \mu$ s + the delay between the end of a sync and rising edge of SENABLE. This will prevent the sync processor from generating invalid sync signals due to the spikes.
3. If the Sync Processor is external to the design with the ISL5992x (video with Sync-On-Green, for example), the video signal should disconnected from the ISL59920 and shorted to ground via an analog switch for the first $x$ microseconds after a valid sync, where $x=3 \mu \mathrm{~s}+$ the delay between the end of a sync and rising edge of SENABLE. This will remove the calibration signals from the video signal.

These steps are only necessary if the sync signal is embedded on the video and you want to avoid possible monitor blanking during skew adjustment.

## Test Pins

Three test pins are provided (Test R, Test G, Test B). During normal operation, the test pins output pulses of current for a duration of the overlap between the inputs, as shown in Figure 34:
$\mathrm{TEST}_{\mathrm{R}}$ pulse $=$ RED $_{\text {OUT }}(\mathrm{A})$ with respect to GREEN OUT $(B)$
$\mathrm{TEST}_{\mathrm{G}}$ pulse $=$ GREEN OUT with respect to BLUEOUT
$\mathrm{TEST}_{\mathrm{B}}$ pulse $=$ BLUE $_{\text {OUT }}$ with respect to RED $_{\text {OUT }}$
Averaging the current gives a direct measure of the delay between the two edges. When $A$ precedes $B$, the current pulse is $+50 \mu \mathrm{~A}$, and the output voltage goes up. When $B$ precedes $A$, the pulse is $-50 \mu \mathrm{~A}$.
For the logic to work correctly, A and B must have a period of overlap while they are high (a delay longer than the pulse width cannot be measured).

Signals A and B are derived from the video input by comparing the video signal with a slicing level, which is set by an internal DAC. This enables the delay to be measured either from the rising edges of sync-like signals encoded on top of the video or from a dedicated set-up signal. The outputs can be used to set the correct delays for the signals received.
The DAC level is set through the serial input by bits 1 through 4 directed to the test register (00).

## Internal DAC Voltage

The slice level of the internal DAC may be programmed by writing a byte to the test register (00). Table 3 shows the values that should be written to change the DAC slice level. Please keep in mind when writing to the test register that the LSB should always be zero.
Referred to the input, the DAC slice range for the ISL5992x is cut in half for gain of 2 mode because the slicing occurs after the $\times 1 / x 2$ stage output amplifier. (In the EL9115, the slicing occurred before the amplifier so the range of the DAC voltage was the same for either gain of 1 or gain of 2 ).


FIGURE 34. DELAY DETECTOR
TABLE 3. DAC VOLTAGE RANGE - INPUT REFERRED

| wxyz | DAC RANGE [mV] <br> (GAIN 1) | DAC RANGE [mV] <br> (GAIN 2) |
| :---: | :---: | :---: |
| 1000 | -400 | -200 |
| 1001 | -350 | -175 |
| 1010 | -300 | -150 |
| 1011 | -250 | -125 |
| 1100 | -200 | -100 |
| 1101 | -150 | -75 |
| 1110 | -100 | -50 |
| 1111 | -50 | -25 |
| 0000 | 0 | 0 |
| 0001 | 50 | 25 |
| 0010 | 100 | 50 |
| 0011 | 200 | 75 |
| 0100 | 250 | 100 |
| 0101 | 300 | 125 |
| 0110 | 350 | 150 |
| 0111 |  | -175 |

NOTE: Test Register word $=000 w x y z 0$. wxyz fed to DAC. $z$ is LSB

## Power Dissipation

As the delay setting increases, additional filter blocks turn on and insert into the signal path. When the delay per channel increments, $\mathrm{V}_{\mathrm{SP}}$ current increases by 0.9 mA while $\mathrm{V}_{\mathrm{SM}}$ does not change significantly. Under the extreme settings, the positive supply current reaches 141 mA and the negative supply current can be 41 mA . Operating at $\pm 5 \mathrm{~V}$ power supply, the worst-case ISL5992x power dissipation is:

$$
P D=5 \bullet 141 \mathrm{~mA}+5 \bullet 41 \mathrm{~mA}=910 \mathrm{~mW} \quad \text { (EQ. 1) }
$$

The minimum $\theta_{\mathrm{JA}}$ required for long term reliable operation of the ISL5992x is calculated using Equation 2:
$\theta_{J A}=\left(T_{J}-T_{A}\right) / P D=55^{\circ} \mathrm{C} / \mathrm{W}$
Where:
$T_{J}$ is the maximum junction temperature $\left(+135^{\circ} \mathrm{C}\right)$
$\mathrm{T}_{\mathrm{A}}$ is the maximum ambient temperature $\left(+85^{\circ} \mathrm{C}\right)$
For a 20 Ld package on a well laid-out PCB with good connectivity between the QFN's pad and the PCB copper area, $31^{\circ} \mathrm{C} / \mathrm{W} \theta_{\mathrm{JA}}$ thermal resistance can be achieved. This yields a much higher power dissipation of 3.54 W using Equation 2 (see Figure 31). To disperse the heat, the bottom heat spreader must be soldered to the PCB. Heat flows through the heat spreader to the circuit board copper then spreads and convects to air. Thus, the PCB copper plane becomes the heatsink (see TB389). This has proven to be a very effective technique. A separate application note, which details the 20 Ld QFN PCB design considerations, is available.

## Quad Flat No-Lead Plastic Package (QFN)



L20.5x5C
20 LEAD QUAD FLAT NO-LEAD PLASTIC PACKAGE (COMPLIANT TO JEDEC MO-220)

| SYMBOL | MILLIMETERS |  |  | NOTES |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN | NOMINAL | MAX |  |
| A | 0.80 | 0.90 | 1.00 | - |
| A1 | 0.00 | 0.02 | 0.05 | - |
| b | 0.28 | 0.30 | 0.32 | - |
| c | 0.20 REF |  |  | - |
| D | 5.00 BASIC |  |  | - |
| D2 | 3.70 REF |  |  | 8 |
| E | 5.00 BASIC |  |  | - |
| E2 | 0.60 REF |  |  | 8 |
| e | 0.65 BSIC |  |  | - |
| L | 0.35 | 0.40 | 0.45 | - |
| N | 20 |  |  | 4 |
| ND | 5 REF |  |  | 6 |
| NE | 5 REF |  |  | 5 |

NOTES:

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Tiebar view shown is a non-functional feature.
3. Bottom-side pin \#1 I.D. is a diepad chamfer as shown.
4. $N$ is the total number of terminals on the device.
5. NE is the number of terminals on the " $E$ " side of the package (or Y -direction).
6. ND is the number of terminals on the " D " side of the package (or X-direction). ND = (N/2)-NE.
7. Inward end of terminal may be square or circular in shape with radius (b/2) as shown.
8. If two values are listed, multiple exposed pad options are available. Refer to device-specific datasheet.
9. One of 10 packages in MDP0046

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